Search Notes



Application/Control No.	Applicant(s)/Paten Reexamination	Applicant(s)/Patent under Reexamination	
10/525,259	WAN, MARGARET SIN KA		
Examiner	Art Unit		
Susan E. Fernandez	1651		

SEARCHED				
Class	Subclass	Date	Examiner	
435	325,366, 398,399	11/29/2006	SEF	
,				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
EAST: US-PGPUB, USPAT, EPO, JPO, DERWENTsee search history	11/29/2006	SEF		
STN: CAPLUS, BIOSISsee search history	11/29/2006	SEF		
inventor name search: STN and PALM	11/29/2006	SEF		